

MOSFET - Power, Single P-Channel

-40 V, 23 mΩ, -34.6 A

NVMFS025P04M8L

Features

- NVMFWS025P04M8L Wettable Flanks Product
- Small Footprint for Compact Design 5 x 6 mm
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_{.J} = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	-40	V
Gate-to-Source Voltage			V_{GS}	±20	V
Continuous Drain	Steady State	T _C = 25°C	I _D	-34.6	Α
Current R _{θJC} (Notes 1, 2, 3, 4)		T _C = 100°C	1	-24.5	
Power Dissipation		T _C = 25°C	P_{D}	44.1	W
$R_{\theta JC}$ (Notes 1, 2, 3)		T _C = 100°C	1	22.1	
Continuous Drain		T _A = 25°C	I _D	-9.4	Α
Current R _{θJA} (Notes 1, 3, 4)	Steady State	T _A = 100°C	1	-6.6	
Power Dissipation		T _A = 25°C	P_{D}	3.5	W
$R_{\theta JA}$ (Notes 1, 3)		T _A = 100°C		1.8	
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \mu s$		I _{DM}	204	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			IS	36.8	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = TBD A)			E _{AS}	152	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

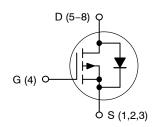
THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 3)	$R_{\theta JC}$	3.4	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	42.4	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- Psi (Ψ) is used as required per JESD51–12 for packages in which substantially less than 100% of the heat flows to single case surface.
- 3. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

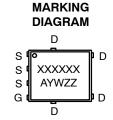
V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
-40 V	23 mΩ @ –10 V	-34.6 A
-40 v	37 mΩ @ -4.5 V	-04.0 A

P-Channel MOSFET





STYLE 1



XXXXXX = Specific Device Code

A = Assembly Location

Y = Year W = Work Week ZZ = Lot Traceability

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS					•		·
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		-40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				20.40		mV/° C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			-1	μΑ
		$V_{GS} = 0 V$, $V_{DS} = -40 V$	T _J = 125°C			-100	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS}$	_S = ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D =$	= -255 μA	-1.0		-2.4	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} / T _J				4.94		mV/° C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = -10 V, I _D = -15 A			16.6	23	mΩ
		$V_{GS} = -4.5 \text{ V}, I_{I}$	₀ = -7.5 A		23.6	37	
Forward Transconductance	9FS	$V_{DS} = -1.5 \text{ V}, \text{ I}$	_D = -15 A		30.8		S
CHARGES AND CAPACITANCES					-	•	
Input Capacitance	C _{iss}	V _{GS} = 0 V, f =	1.0 MHz,		1058		pF
Output Capacitance	C _{oss}	V _{DS} = -20 V			446		
Reverse Transfer Capacitance	C _{rss}				19		
Plateau Voltage	V_{GP}				2.9		V
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = -4.5 \text{ V}, V_{DS} = -20 \text{ V},$ $I_D = -7.5 \text{ A}$			7.56		nC
Threshold Gate Charge	Q _{G(TH)}				1.93		nC
Gate-to-Source Charge	Q_{GS}				3.4		
Gate-to-Drain Charge	Q_{GD}				1.55		
Total Gate Charge	$Q_{G(TOT)}$	$V_{GS} = -10 \text{ V}, V_{DS} = -20 \text{ V},$ $I_{D} = -7.5 \text{ A}$			16.3		nC
SWITCHING CHARACTERISTICS (No	ote 6)						
Turn-On Delay Time	t _{d(on)}				16		ns
Rise Time	t _r	$V_{GS} = -4.5 \text{ V}, V_{D}$	₁₉ = -20 V,		99		
Turn-Off Delay Time	t _{d(off)}	$I_D = -7.5 \text{ A}, R_G = 2.5 \Omega$			50		
Fall Time	t _f				58		
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V,	T _J = 25°C		-0.86	-1.20	V
		$I_S = -15 \text{A}$	T _J = 125°C		-0.78		1
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = -15 \text{ A}$			39		ns
Charge Time	t _a				31		1
Discharge Time	t _b				8		1
Reverse Recovery Charge	Q_{RR}				35		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: Pulse Width \leq 300 µs, Duty Cycle \leq 2%.

TYPICAL CHARACTERISTICS

^{6.} Switching characteristics are independent of operating junction temperatures.

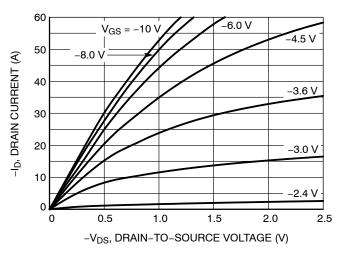


Figure 1. On-Region Characteristics

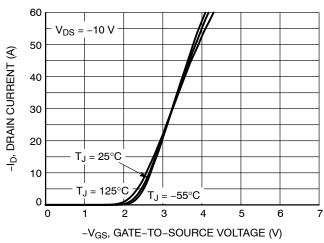


Figure 2. Transfer Characteristics

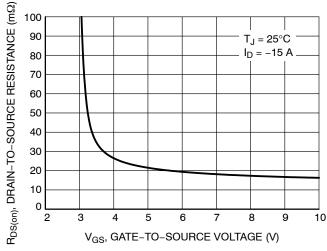


Figure 3. On-Resistance vs. Gate-to-Source Voltage

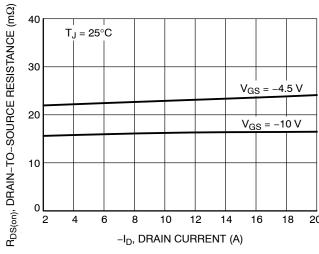


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

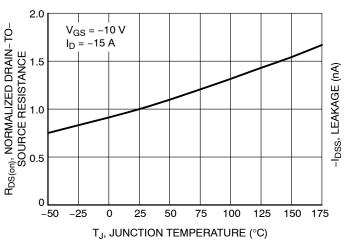


Figure 5. On–Resistance Variation with Temperature

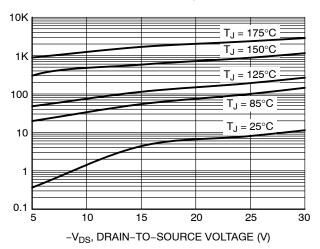


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

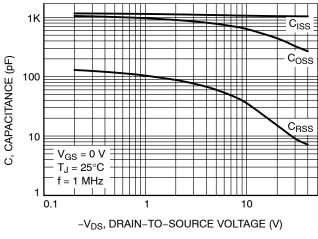


Figure 7. Capacitance Variation

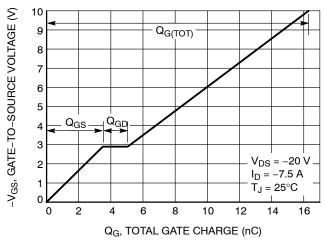


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

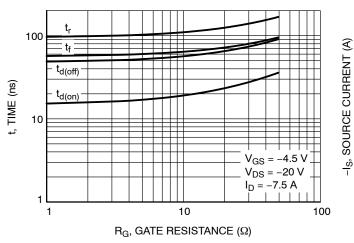


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

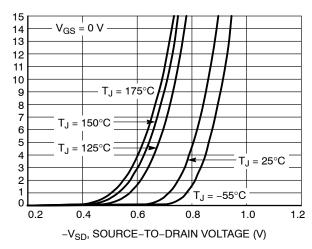


Figure 10. Diode Forward Voltage vs. Current

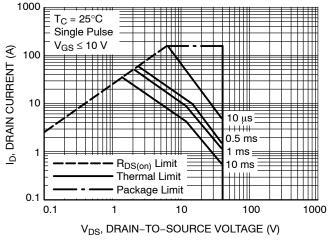


Figure 11. Safe Operating Area

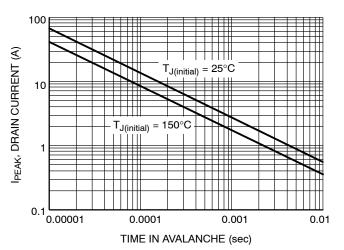


Figure 12. I_{PEAK} vs. Time in Avalanche

TYPICAL CHARACTERISTICS

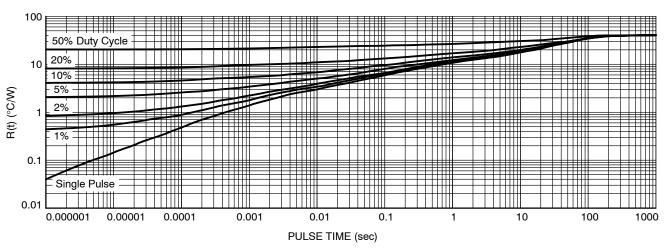


Figure 13. Thermal Characteristics

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NVMFS025P04M8LT1G	025P04	SO8FL	1500 / Tape & Reel
NVMFWS025P04M8LT1G	025P4W	(Pb-Free)	

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





DFN5 5x6, 1.27P (SO-8FL) CASE 488AA ISSUE N

DATE 25 JUN 2018

NOTES:

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETER. DIMENSION D1 AND E1 DO NOT INCLUDE
- MOLD FLASH PROTRUSIONS OR GATE BURRS

	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	0.90	1.00	1.10		
A1	0.00	-	0.05		
b	0.33	0.41	0.51		
С	0.23	0.28	0.33		
D	5.00	5.15	5.30		
D1	4.70	4.90	5.10		
D2	3.80	4.00	4.20		
E	6.00	6.15	6.30		
E1	5.70	5.90	6.10		
E2	3.45	3.65	3.85		
е		1.27 BSC	;		
G	0.51	0.575	0.71		
K	1.20	1.35	1.50		
L	0.51	0.575	0.71		
L1	0.125 REF				
M	3.00	3.40	3.80		
θ	0 °		12 °		

GENERIC MARKING DIAGRAM*

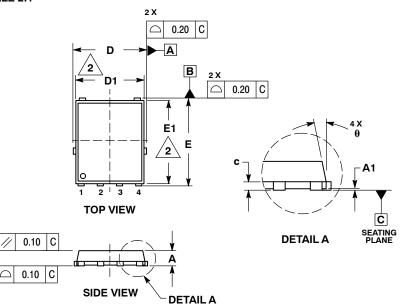


XXXXXX = Specific Device Code

= Assembly Location Α

Υ = Year W = Work Week ZZ = Lot Traceability

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ", may or may not be present. Some products may not follow the Generic Marking.





*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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